74HC165-Q100; 74HCT165-Q100

8-bit parallel-in/serial out shift register

Rev. 1 — 17 July 2012

Product data sheet

1. General description

The 74HC165-Q100; 74HCT165-Q100 are high-speed Si-gate CMOS devices that comply with JEDEC standard no. 7A. They are pin compatible with Low-power Schottky TTL (LSTTL).

The 74HC165-Q100; 74HCT165-Q100 are <u>8-bit parallel-load</u> or serial-in shift registers with complementary serial outputs (Q7 and $\overline{Q7}$) available from the last stage. When the parallel load (\overline{PL}) input is LOW, parallel data from the D0 to D7 inputs are loaded into the register asynchronously.

When \overline{PL} is HIGH, data enters the register serially at the DS input and shifts one place to the right (Q0 \rightarrow Q1 \rightarrow Q2, etc.) with each positive-going clock transition. This feature allows parallel-to-serial converter expansion by tying the Q7 output to the DS input of the succeeding stage.

The clock input is a gated-OR structure which allows one input to be used as an active LOW clock enable (CE) input. The pin assignment for the CP and CE inputs is arbitrary and can be reversed for layout convenience. The LOW-to-HIGH transition of input CE should only take place while CP HIGH for predictable operation. Either the CP or the CE should be HIGH before the LOW-to-HIGH transition of PL to prevent shifting the data when PL is activated.

This product has been qualified to the Automotive Electronics Council (AEC) standard Q100 (Grade 1) and is suitable for use in automotive applications.

2. Features and benefits

- Automotive product qualification in accordance with AEC-Q100 (Grade 1)
 - ◆ Specified from -40 °C to +85 °C and from -40 °C to +125 °C
- Asynchronous 8-bit parallel load
- Synchronous serial input
- Complies with JEDEC standard no. 7A
- ESD protection:
 - MIL-STD-883, method 3015 exceeds 2000 V
 - HBM JESD22-A114F exceeds 2000 V
 - lacktriangle MM JESD22-A115-A exceeds 200 V (C = 200 pF, R = 0 Ω)
- Multiple package options

3. Applications

Parallel-to-serial data conversion

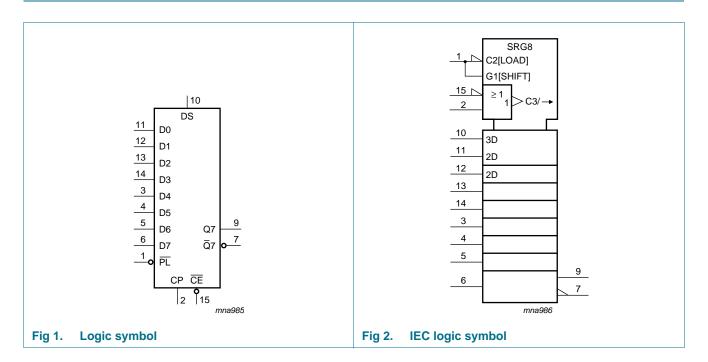


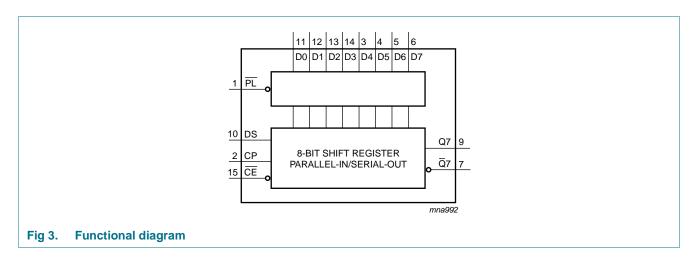
4. Ordering information

Table 1. Ordering information

Type number	Package				
	Temperature range	Name	Description	Version	
74HC165D-Q100	–40 °C to +125 °C	SO16	plastic small outline package; 16 leads; body width	SOT109-1	
74HCT165D-Q100			3.9 mm		
74HC165PW-Q100	-40 °C to +125 °C TSSOP16		plastic thin shrink small outline package; 16 leads;	SOT403-1	
74HCT165PW-Q100			body width 4.4 mm		
74HC165BQ-Q100	–40 °C to +125 °C	DHVQFN16	plastic dual in-line compatible thermal enhanced	SOT763-1	
74HCT165BQ-Q100	_		very thin quad flat package; no leads; 16 terminals; body $2.5 \times 3.5 \times 0.85$ mm		

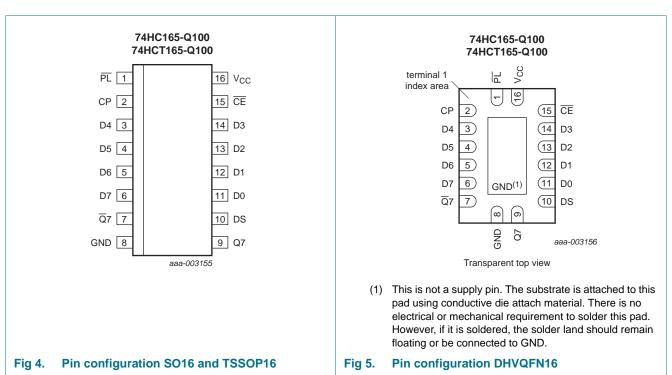
5. Functional diagram





6. Pinning information

6.1 Pinning



6.2 Pin description

Table 2. Pin description

Symbol	Pin	Description
PL	1	asynchronous parallel load input (active LOW)
CP	2	clock input (LOW-to-HIGH edge-triggered)
Q7	7	complementary output from the last stage
GND	8	ground (0 V)
Q7	9	serial output from the last stage
DS	10	serial data input
D0 to D7	11, 12, 13, 14, 3, 4, 5, 6	parallel data inputs (also referred to as Dn)
CE	15	clock enable input (active LOW)
V _{CC}	16	positive supply voltage

7. Functional description

Table 3. Function table[1]

Operating modes	Inputs					Qn regi	sters	Outputs	
	PL	CE	СР	DS	D0 to D7	Q0	Q1 to Q6	Q7	Q7
parallel load	L	X	Χ	X	L	L	L to L	L	Н
	L	Χ	Χ	Χ	Н	Н	H to H	Н	L
serial shift	Н	L	↑	I	Χ	L	q0 to q5	q6	q 6
	Н	L	↑	h	Χ	Н	q0 to q5	q6	q 6
	Н	↑	L	I	Χ	L	q0 to q5	q6	q 6
	Н	↑	L	h	Χ	Н	q0 to q5	q6	q 6
hold "do nothing"	Н	Н	X	Х	Χ	q0	q1 to q6	q7	q 7
	Н	Χ	Н	Χ	Χ	q0	q1 to q6	q7	q 7

^[1] H = HIGH voltage level;

h = HIGH voltage level one set-up time prior to the LOW-to-HIGH clock transition;

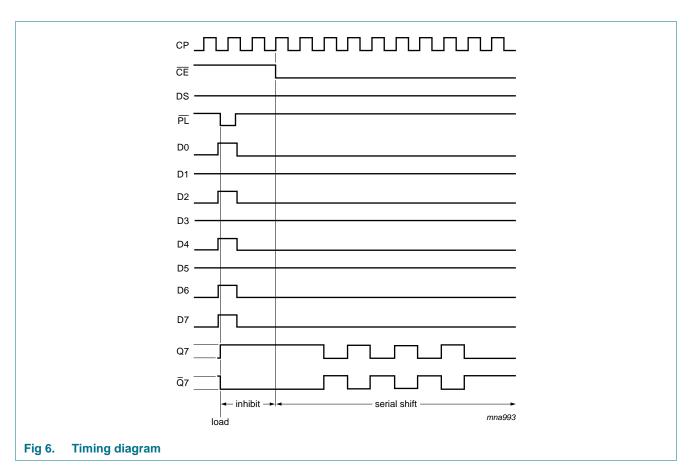
L = LOW voltage level;

I = LOW voltage level one set-up time prior to the LOW-to-HIGH clock transition;

q = state of the referenced output one set-up time prior to the LOW-to-HIGH clock transition;

X = don't care;

 $[\]uparrow$ = LOW-to-HIGH clock transition.



8. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V)

Symbol	Parameter	Conditions	Min	Max	Unit
V_{CC}	supply voltage		-0.5	+7	V
I _{IK}	input clamping current	$V_I < -0.5 \text{ V or } V_I > V_{CC} + 0.5 \text{ V}$	<u>[1]</u> _	±20	mA
I _{OK}	output clamping current	$V_O < -0.5 \text{ V or } V_O > V_{CC} + 0.5 \text{ V}$	<u>[1]</u> _	±20	mA
I _O	output current	$-0.5 \text{ V} < \text{V}_{\text{O}} < \text{V}_{\text{CC}} + 0.5 \text{ V}$	-	±25	mA
I _{CC}	supply current		-	50	mA
I _{GND}	ground current		-50	-	mA
T _{stg}	storage temperature		-65	+150	°C
P _{tot}	total power dissipation	$T_{amb} = -40 ^{\circ}\text{C}$ to +125 $^{\circ}\text{C}$	[2] _	500	mW

^[1] The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

^[2] For SO16 package: P_{tot} derates linearly with 8 mW/K above 70 °C. For TSSOP16 package: P_{tot} derates linearly with 5.5 mW/K above 60 °C. For DHVQFN16 package: P_{tot} derates linearly with 4.5 mW/K above 60 °C.

9. Recommended operating conditions

Table 5. Recommended operating conditions

Voltages are referenced to GND (ground = 0 V)

Symbol	Parameter	Conditions	74HC1	65-Q100		74HCT165-Q100			Unit
			Min	Тур	Max	Min	Тур	Max	
V_{CC}	supply voltage		2.0	5.0	6.0	4.5	5.0	5.5	V
VI	input voltage		0	-	V_{CC}	0	-	V_{CC}	V
Vo	output voltage		0	-	V_{CC}	0	-	V_{CC}	V
T _{amb}	ambient temperature		-40	-	+125	-40	-	+125	°C
Δt/ΔV	input transition rise and fall rate	$V_{CC} = 2.0 \text{ V}$	-	-	625	-	-	-	ns/V
		V _{CC} = 4.5 V	-	1.67	139	-	1.67	139	ns/V
		$V_{CC} = 6.0 \text{ V}$	-	-	83	-	-	-	ns/V

10. Static characteristics

Table 6. Static characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		25 °C		-40 °C t	o +85 °C	-40 °C to +125 °C		Unit
			Min	Тур	Max	Min	Max	Min	Max	
74HC16	5-Q100					'	'			1
V_{IH}	HIGH-level	$V_{CC} = 2.0 \text{ V}$	1.5	1.2	-	1.5	-	1.5	-	V
	input voltage	V _{CC} = 4.5 V	3.15	2.4	-	3.15	-	3.15	-	V
		$V_{CC} = 6.0 \text{ V}$	4.2	3.2	-	4.2	-	4.2	-	V
V_{IL}	LOW-level	V _{CC} = 2.0 V	-	0.8	0.5	-	0.5	-	0.5	V
	input voltage	$V_{CC} = 4.5 \text{ V}$	-	2.1	1.35	-	1.35	-	1.35	V
	$V_{CC} = 6.0 \text{ V}$	-	2.8	1.8	-	1.8	-	1.8	V	
V_{OH}	HIGH-level	$V_I = V_{IH}$ or V_{IL}								
	output voltage	$I_O = -20 \mu A; V_{CC} = 2.0 V$	1.9	2.0	-	1.9	-	1.9	-	V
		$I_O = -20 \mu A; V_{CC} = 4.5 V$	4.4	4.5	-	4.4	-	4.4	-	V
		$I_O = -20 \mu A; V_{CC} = 6.0 V$	5.9	6.0	-	5.9	-	5.9	-	V
		$I_{O} = -4.0 \text{ mA}; V_{CC} = 4.5 \text{ V}$	3.98	4.32	-	3.84	-	3.7	-	V
		$I_{O} = -5.2 \text{ mA}; V_{CC} = 6.0 \text{ V}$	5.48	5.81	-	5.34	-	5.2	-	V
V_{OL}	LOW-level	$V_I = V_{IH}$ or V_{IL}								
	output voltage	$I_O = 20 \mu A; V_{CC} = 2.0 V$	-	0	0.1	-	0.1	-	0.1	V
		$I_O = 20 \mu A; V_{CC} = 4.5 V$	-	0	0.1	-	0.1	-	0.1	V
		$I_O = 20 \mu A; V_{CC} = 6.0 V$	-	0	0.1	-	0.1	-	0.1	V
		$I_O = 4.0 \text{ mA}$; $V_{CC} = 4.5 \text{ V}$	-	0.15	0.26	-	0.33	-	0.4	V
		$I_O = 5.2 \text{ mA}; V_{CC} = 6.0 \text{ V}$	-	0.16	0.26	-	0.33	-	0.4	V
I _I	input leakage current	$V_I = V_{CC}$ or GND; $V_{CC} = 6.0 \text{ V}$	-	-	±0.1	-	±1	-	±1	μΑ
I _{CC}	supply current	$V_I = V_{CC}$ or GND; $I_O = 0$ A; $V_{CC} = 6.0 \text{ V}$	-	-	8.0	-	80	-	160	μΑ

 Table 6.
 Static characteristics ...continued

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		25 °C		-40 °C	to +85 °C	-40 °C to	-40 °C to +125 °C		
			Min	Тур	Max	Min	Max	Min	Max		
C _I	input capacitance		-	3.5	-	-	-	-	-	pF	
74HCT1	65-Q100										
V_{IH}	HIGH-level input voltage	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	2.0	1.6	-	2.0	-	2.0	-	V	
V_{IL}	LOW-level input voltage	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	-	1.2	8.0	-	0.8	-	0.8	V	
V_{OH}	HIGH-level	$V_I = V_{IH}$ or V_{IL} ; $V_{CC} = 4.5 \text{ V}$									
	output voltage	$I_{O} = -20 \mu A$	4.4	4.5	-	4.4	-	4.4	-	V	
		$I_{O} = -4.0 \text{ mA}$	3.98	4.32	-	3.84	-	3.7	-	V	
V _{OL}	LOW-level	$V_I = V_{IH}$ or V_{IL} ; $V_{CC} = 4.5 \text{ V}$									
	output voltage	$I_O = 20 \mu A; V_{CC} = 4.5 V$	-	0	0.1	-	0.1	-	0.1	V	
		I_{O} = 5.2 mA; V_{CC} = 6.0 V	-	0.16	0.26	-	0.33	-	0.4	V	
l _l	input leakage current	$V_I = V_{CC}$ or GND; $V_{CC} = 6.0 \text{ V}$	-	-	±0.1	-	±1	-	±1	μΑ	
I _{CC}	supply current	$V_I = V_{CC}$ or GND; $I_O = 0$ A; $V_{CC} = 6.0$ V	-	-	8.0	-	80	-	160	μΑ	
Δl _{CC}	additional supply current	per input pin; $V_{I} = V_{CC} - 2.1 \text{ V};$ other inputs at V_{CC} or GND; $V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$									
		Dn and DS inputs	-	35	126	-	157.5	-	171.5	μΑ	
		$CP \overline{CE}$, and \overline{PL} inputs	-	65	234	-	292.5	-	318.5	μΑ	
Cı	input capacitance		-	3.5	-	-	-	-	-	pF	

11. Dynamic characteristics

Table 7. Dynamic characteristics

GND (ground = 0 V); $C_L = 50 \text{ pF}$ unless otherwise specified; for test circuit, see <u>Figure 12</u>

Symbol	ool Parameter Conditions		25 °C	;	-40 °C 1	o +85 °C	-40 °C to +125 °C		Unit	
			Min	Тур	Max	Min	Max	Min	Max	
74HC16	5-Q100									
t _{pd}	propagation delay	CP or \overline{CE} to Q7, \overline{Q} 7; see Figure 7]							
		V _{CC} = 2.0 V	-	52	165	-	205	-	250	ns
		V _{CC} = 4.5 V	-	19	33	-	41	-	50	ns
		$V_{CC} = 6.0 \text{ V}$	-	15	28	-	35	-	43	ns
		$V_{CC} = 5.0 \text{ V}; C_L = 15 \text{ pF}$	-	16	-	-	-	-	-	ns
		PL to Q7, Q7; see Figure 8								
		V _{CC} = 2.0 V	-	50	165	-	205	-	250	ns
		V _{CC} = 4.5 V	-	18	33	-	41	-	50	ns
		$V_{CC} = 6.0 \text{ V}$	-	14	28	-	35	-	43	ns
		$V_{CC} = 5.0 \text{ V}; C_L = 15 \text{ pF}$	-	15	-	-	-	-	-	ns
		D7 to Q7, Q7; see Figure 9								
		V _{CC} = 2.0 V	-	36	120	-	150	-	180	ns
		V _{CC} = 4.5 V	-	13	24	-	30	-	36	ns
		V _{CC} = 6.0 V	-	10	20	-	26	-	31	ns
		$V_{CC} = 5.0 \text{ V}; C_L = 15 \text{ pF}$	-	11	-	-	-	-	-	ns
t _t	transition	Q7, Q7 output; see Figure 7	1							
	time	$V_{CC} = 2.0 \text{ V}$	-	19	75	-	95	-	110	ns
		$V_{CC} = 4.5 \text{ V}$	-	7	15	-	19	-	22	ns
		$V_{CC} = 6.0 \text{ V}$	-	6	13	-	16	-	19	ns
t_W	pulse width	CP input HIGH or LOW; see Figure 7								
		V _{CC} = 2.0 V	80	17	-	100	-	120	-	ns
		V _{CC} = 4.5 V	16	6	-	20	-	24	-	ns
		V _{CC} = 6.0 V	14	5	-	17	-	20	-	ns
		PL input LOW; see Figure 8								
		V _{CC} = 2.0 V	80	14	-	100	-	120	-	ns
		V _{CC} = 4.5 V	16	5	-	20	-	24	-	ns
		V _{CC} = 6.0 V	14	4	-	17	-	20	-	ns
t _{rec}	recovery time	PL to CP, CE; see Figure 8								
		V _{CC} = 2.0 V	100	22	-	125	-	150	-	ns
		V _{CC} = 4.5 V	20	8	-	25	-	30	-	ns
		V _{CC} = 6.0 V	17	6	-	21	-	26	-	ns

 Table 7.
 Dynamic characteristics ...continued

GND (ground = 0 V); $C_L = 50$ pF unless otherwise specified; for test circuit, see Figure 12

Symbol	Parameter	Conditions		25 °C	;	-40 °C	to +85 °C	-40 °C to +125 °C		Unit
			Min	Тур	Max	Min	Max	Min	Max	
t _{su}	set-up time	DS to CP, CE; see Figure 10				1				
		$V_{CC} = 2.0 \text{ V}$	80	11	-	100	-	120	-	ns
		$V_{CC} = 4.5 \text{ V}$	16	4	-	20	-	24	-	ns
		$V_{CC} = 6.0 \text{ V}$	14	3	-	17	-	20	-	ns
		CE to CP and CP to CE; see Figure 10								
		$V_{CC} = 2.0 \text{ V}$	80	17	-	100	-	120	-	ns
		V _{CC} = 4.5 V	16	6	-	20	-	24	-	ns
		$V_{CC} = 6.0 \text{ V}$	14	5	-	17	-	20	-	ns
		Dn to PL; see Figure 11								
		$V_{CC} = 2.0 \text{ V}$	80	22	-	100	-	120	-	ns
		$V_{CC} = 4.5 \text{ V}$	16	8	-	20	-	24	-	ns
		$V_{CC} = 6.0 \text{ V}$	14	6	-	17	-	20	-	ns
t _h	hold time	DS to CP, CE and Dn to PL; see Figure 10								
		$V_{CC} = 2.0 \text{ V}$	5	6	-	5	-	5	-	ns
		$V_{CC} = 4.5 \text{ V}$	5	2	-	5	-	5	-	ns
		$V_{CC} = 6.0 \text{ V}$	5	2	-	5	-	5	-	ns
		CE to CP and CP to CE; see Figure 10								
		$V_{CC} = 2.0 \text{ V}$	5	-17	-	5	-	5	-	ns
		$V_{CC} = 4.5 \text{ V}$	5	-6	-	5	-	5	-	ns
		$V_{CC} = 6.0 \text{ V}$	5	-5	-	5	-	5	-	ns
f _{max}	maximum	CP input; see Figure 7								
	frequency	$V_{CC} = 2.0 \text{ V}$	6	17	-	5	-	4	-	MHz
		$V_{CC} = 4.5 \text{ V}$	30	51	-	24	-	20	-	MHz
		V _{CC} = 6.0 V	35	61	-	28	-	24	-	MHz
		$V_{CC} = 5.0 \text{ V}; C_L = 15 \text{ pF}$	-	56	-	-	-	-	-	MHz
C _{PD}	power dissipation capacitance	per package; V _I = GND to V _{CC}	[3] -	35	-	-	-	-	-	pF

 Table 7.
 Dynamic characteristics ...continued

GND (ground = 0 V); $C_L = 50 \text{ pF}$ unless otherwise specified; for test circuit, see Figure 12

Symbol	Parameter	Conditions		25 °C	;	-40 °C	to +85 °C	-40 °C to +125 °C		Unit
			Mii	1 Тур	Max	Min	Max	Min	Max	_
74HCT10	65-Q100									
t _{pd}	propagation delay	$\overline{\text{CE}}$, CP to Q7, $\overline{\text{Q}}$ 7; see Figure 7	1							
		V _{CC} = 4.5 V	-	17	34	-	43	-	51	ns
		$V_{CC} = 5.0 \text{ V}; C_L = 15 \text{ pF}$	-	14	-	-	-	-	-	ns
		PL to Q7, Q7; see Figure 8								
		$V_{CC} = 4.5 \text{ V}$	-	20	40	-	50	-	60	ns
		$V_{CC} = 5.0 \text{ V}; C_L = 15 \text{ pF}$	-	17	-	-	-	-	-	ns
		D7 to Q7, Q7; see Figure 9								
		$V_{CC} = 4.5 \text{ V}$	-	14	28	-	35	-	42	ns
		$V_{CC} = 5.0 \text{ V}; C_L = 15 \text{ pF}$	-	11	-	-	-	-	-	ns
t _t	transition	Q7, Q7 output; see Figure 7	<u>']</u>							
	time	V _{CC} = 4.5 V	-	7	15	-	19	-	22	ns
t _W pı	pulse width	CP input; see Figure 7								
		$V_{CC} = 4.5 \text{ V}$	16	6	-	20	-	24	-	ns
		PL input; see Figure 8								
		$V_{CC} = 4.5 \text{ V}$	20	9	-	25	-	30	-	ns
t _{rec}	recovery time	PL to CP, CE; see Figure 8								
		$V_{CC} = 4.5 \text{ V}$	20	8	-	25	-	30	-	ns
t_{su}	set-up time	DS to CP, CE; see Figure 10								
		$V_{CC} = 4.5 \text{ V}$	20	2	-	25	-	30	-	ns
		CE to CP and CP to CE; see Figure 10								
		V _{CC} = 4.5 V	20	7	-	25	-	30	-	ns
		Dn to PL; see Figure 11								
		V _{CC} = 4.5 V	20	10	-	25	-	30	-	ns
t _h	hold time	DS to CP, \overline{CE} and Dn to \overline{PL} ; see Figure 10								
		V _{CC} = 4.5 V	7	-1	-	9	-	11	-	ns
		CE to CP and CP to CE; see Figure 10								
		V _{CC} = 4.5 V	0	-7	-	0	-	0	-	ns
f_{max}	maximum	CP input; see Figure 7								
	frequency	V _{CC} = 4.5 V	26	44	-	21	-	17	-	MHz
		$V_{CC} = 5.0 \text{ V}; C_L = 15 \text{ pF}$	-	48	-	-	-	-	-	MHz

 Table 7.
 Dynamic characteristics ...continued

GND (ground = 0 V); $C_L = 50$ pF unless otherwise specified; for test circuit, see Figure 12

Symbol	Parameter	Conditions		25 °C		-40 °C to +85 °C		-40 °C to +125 °C		Unit	
			N	Min	Тур	Max	Min	Max	Min	Max	
C_{PD}	power dissipation capacitance	per package; $V_I = GND \text{ to } V_{CC} - 1.5 \text{ V}$	<u>-</u>		35	-	-	-	-	-	pF

- [1] t_{pd} is the same as t_{PHL} and t_{PLH} .
- [2] t_t is the same as t_{THL} and t_{TLH} .
- [3] C_{PD} is used to determine the dynamic power dissipation (P_D in μW).

 $P_D = C_{PD} \times V_{CC}^2 \times f_i + \Sigma (C_L \times V_{CC}^2 \times f_o)$ where:

 f_i = input frequency in MHz;

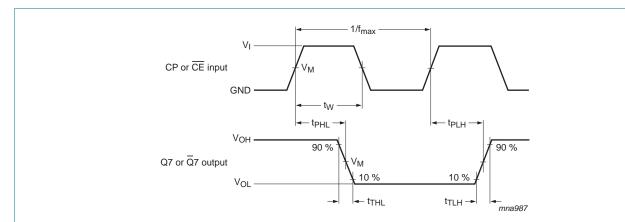
f_o = output frequency in MHz;

 $\Sigma (C_L \times V_{CC}^2 \times f_o)$ = sum of outputs;

C_L = output load capacitance in pF;

 V_{CC} = supply voltage in V.

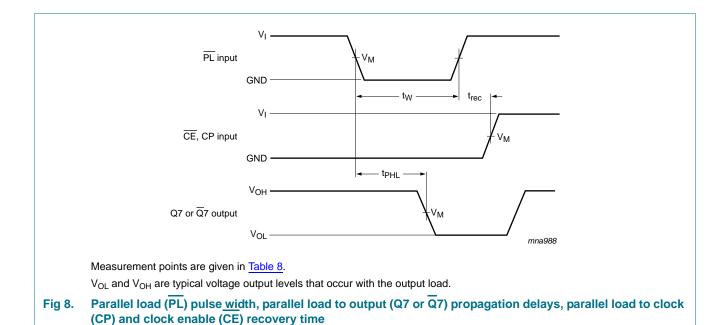
12. Waveforms

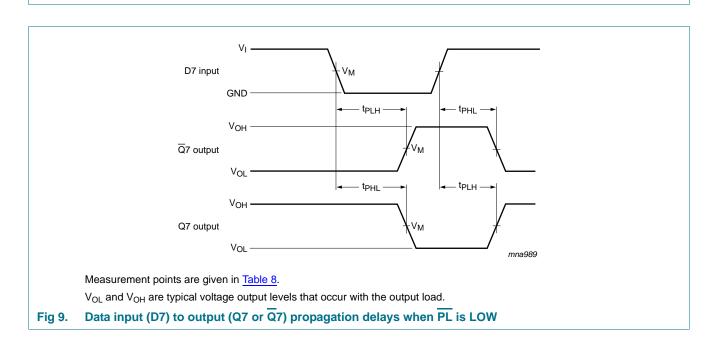


Measurement points are given in Table 8.

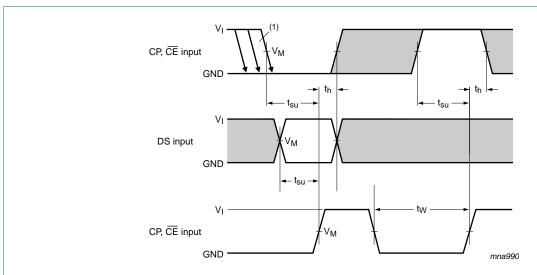
V_{OL} and V_{OH} are typical voltage output levels that occur with the output load.

Fig 7. Clock (CP) or clock enable (CE) to output (Q7 or Q7) propagation delays, clock pulse width, maximum clock frequency and output transition times





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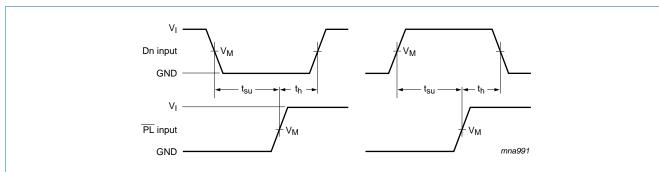


The shaded areas indicate when the input is permitted to change for predictable output performance Measurement points are given in Table 8.

 $V_{\mbox{\scriptsize OL}}$ and $V_{\mbox{\scriptsize OH}}$ are typical voltage output levels that occur with the output load.

(1) $\overline{\text{CE}}$ may change only from HIGH-to-LOW while CP is LOW, see Section 1.

Fig 10. Waveforms showing set-up and hold times



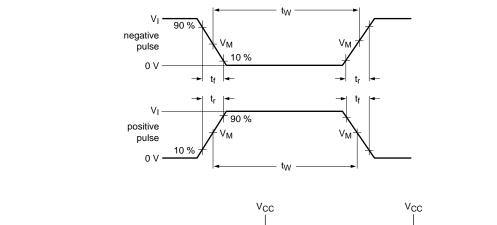
Measurement points are given in Table 8.

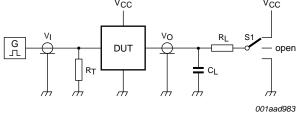
 V_{OL} and V_{OH} are typical voltage output levels that occur with the output load.

Fig 11. The set-up and hold times from the data inputs (Dn) to the parallel load input (PL)

Table 8. Measurement points

Туре	Input	Output	
	VI	V _M	V _M
74HC165-Q100	V _{CC}	0.5V _{CC}	0.5V _{CC}
74HCT165-Q100	3 V	1.3 V	1.3 V





Test data is given in Table 9.

Definitions for test circuit:

 R_T = Termination resistance should be equal to output impedance Z_o of the pulse generator.

 C_L = Load capacitance including jig and probe capacitance.

R_L = Load resistance.

S1 = Test selection switch

Fig 12. Test circuit for measuring switching times

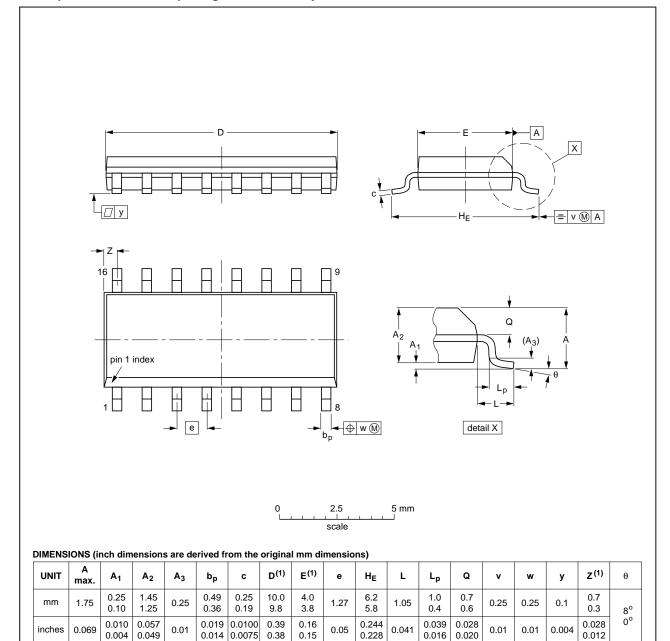
Table 9. Test data

Туре	Input		Load	Load			
	VI	t _r , t _f	C _L	R _L	t _{PHL} , t _{PLH}		
74HC165-Q100	V_{CC}	6 ns	15 pF, 50 pF	1 kΩ	open		
74HCT165-Q100	3 V	6 ns	15 pF, 50 pF	1 kΩ	open		

13. Package outline

SO16: plastic small outline package; 16 leads; body width 3.9 mm

SOT109-1



Note

1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.

OUTLINE VERSION		REFER	EUROPEAN	ICCUIE DATE		
	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
SOT109-1	076E07	MS-012				99-12-27 03-02-19

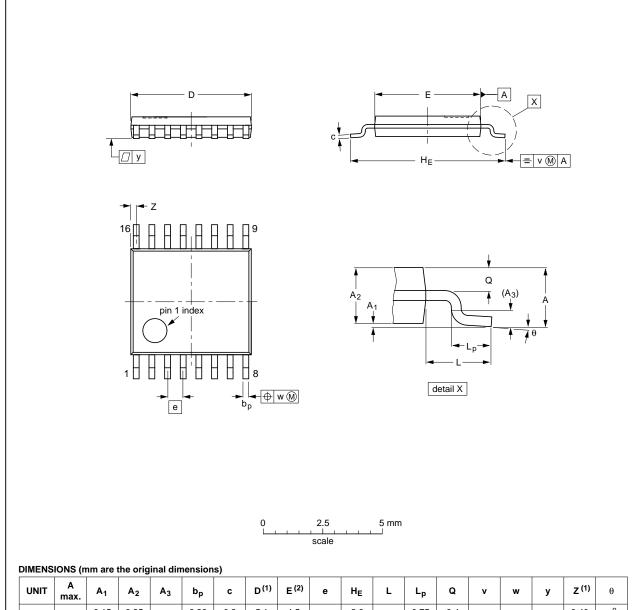
Fig 13. Package outline SOT109-1 (SO16)

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TSSOP16: plastic thin shrink small outline package; 16 leads; body width 4.4 mm

SOT403-1



UNIT	A max.	A ₁	A ₂	A ₃	bp	С	D ⁽¹⁾	E (2)	е	HE	L	Lp	Q	v	w	у	Z ⁽¹⁾	θ
mm	1.1	0.15 0.05	0.95 0.80	0.25	0.30 0.19	0.2 0.1	5.1 4.9	4.5 4.3	0.65	6.6 6.2	1	0.75 0.50	0.4 0.3	0.2	0.13	0.1	0.40 0.06	8° 0°

- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	EUROPEAN	ISSUE DATE			
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE	
SOT403-1		MO-153				99-12-27 03-02-18	

Fig 14. Package outline SOT403-1 (TSSOP16)

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DHVQFN16: plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 16 terminals; body 2.5 x 3.5 x 0.85 mm SOT763-1

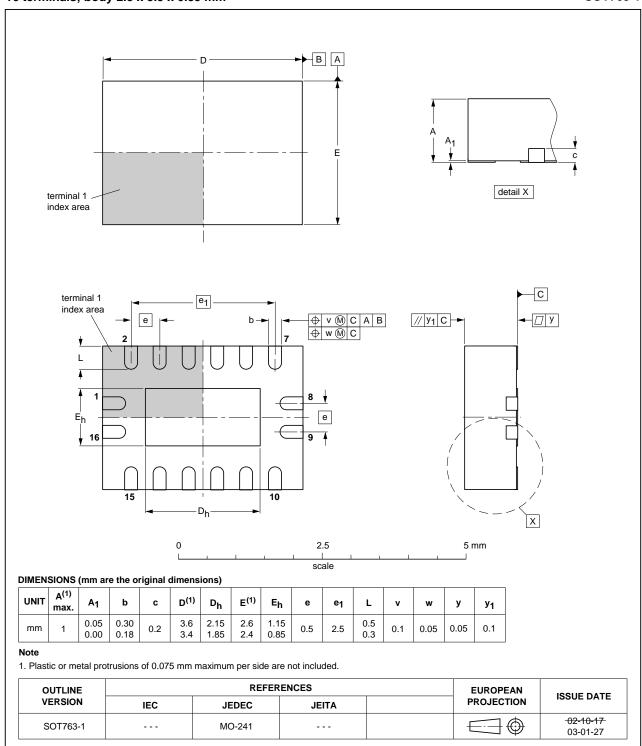


Fig 15. Package outline SOT763-1 (DHVQFN16)

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14. Abbreviations

Table 10. Abbreviations

Acronym	Description
CMOS	Complementary Metal-Oxide Semiconductor
DUT	Device Under Test
ESD	ElectroStatic Discharge
НВМ	Human Body Model
MM	Machine Model
TTL	Transistor-Transistor Logic
MIL	Military

15. Revision history

Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74HC_HCT165_Q100 v.1	20120717	Product data sheet	-	-

16. Legal information

16.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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74HC165-Q100; 74HCT165-Q100

Nexperia

8-bit parallel-in/serial out shift register

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